

Search Notes**Application/Control No.**

10/555,104

Examiner

ANH H. DO

**Applicant(s)/Patent under
Reexamination**

CHEN ET AL.

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner
382	103	9/2/2008	AD
342	52, 195,		
	53		
455	226.3		
702	116, 189,		
	190, 193		
324	164		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PALM EAST (US) EAST (EPO, JPO) EAST (US-PG PUB)	9/2/2008	AD